Search Notes			
	FILTH FILT (ST) IDDI		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/628,612	SHIMIZU ET AL.	
Examiner	Art Unit	
O . Kravil Kaabla	4722	

SEARCHED			
Class	Subclass	Date	Examiner
156	110.1, .123, 133, 134, 405.1	4/15/2005	GL
156	406.4, 64		
702	163	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	V
above &	Jake	1-4-2006	ak
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Reviewed office actions from parent 09/804567	4/15/2005	Æ	
EAST Text Search (attached)	4/15/2005	OK-	
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